

Search Notes

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Applicant(s)/Patent under
Reexamination

KWARK, YOUNG HOON

Art Unit

2829

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
324/750-765;702;356;250/492.2 (text searched only-see history printout)	8/11/2005	EC